Sheet of U.S. DEPARTMENT OF SEMMERCE PATENT AND TRADE ARK OFFICE SERIAL No. Unknown ATTY. DOCKET NO. 29685-74363 10/761,947 INFORMATION DISCLOSURE STATEMENT APPLICANT Blejde et al.. FILING DATE GROUP 1725 (filing receipt) January 21, 2004 U.S. PATENT DOCUMENTS Filing Date if Appropriate Examiner Document Number Date Name Class Subclass nitial 5,934,359 10 Aug 1999 Strezov 6,059,014 09 May 2000 AB Strezov AC ΑD AE AF AG AΗ ΑI ΑJ ΑK FOREIGN PATENT DOCUMENTS Document Number Date Country Class Subclass Translation Yes AL WO 03/024644 A1 27 Mar 2003 PCT х AM WO 00/07753 17 Feb 2000 PCT X ΑN ΑO ΑP OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) "Scanning Electron Microscopy and X-Ray Microanalysis", A Text for Biologists, Materials Scientists, and Geologists, ٩R Second Edition, 1992, Chapter 8 48 ΑT ٩V ΑW ΑX ΑZ caminer Date Considered 90

braw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609.